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1 Electrical ratings

Symbol	Parameter	Va	lue	Unit
		TO-220	TO-220FP	
V_{DS}	Drain-source voltage ($V_{GS} = 0$)	6	60	V
V _{GS}	Gate- source voltage	±	20	V
I _D	Drain current (continuous) at $T_C = 25^{\circ}C$	16	11 ⁽¹⁾	А
I _D	Drain current (continuous) at $T_C = 100^{\circ}C$	11	7.5 ⁽¹⁾	А
I _{DM} ⁽²⁾	Drain current (pulsed)	64	44 ⁽¹⁾	А
P _{tot}	Total dissipation at $T_{C} = 25^{\circ}C$	45	25	W
	Derating factor	0.3	0.17	W/°C
dv/dt ⁽³⁾	Peak diode recovery voltage slope 20			
E _{AS} ⁽⁴⁾	Single pulse avalanche energy	130		
I _{AR}	Avalanche current, repetitive or not- repetitive 16			А
V _{ISO}	Insulation withstand voltage (DC) 2500			
T _{stg}	Storage temperature	EE +	a 175	°C
Тj	Max. operating junction temperature	-55 to 175 °C		

Table 1. Ab	solute maximum	ratings
-------------	----------------	---------

1. Current limited by package's thermal resistance

2. Pulse width limited by safe operating area.

3. $I_{SD} \leq 16A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $Tj \leq T_{JMAX}$

4. Starting T_j = 25 °C, I_D = 8A, V_{DD} = 30V

Table 2.Thermal data

	TO-220 TO-220FP			
Rthj-case	Thermal resistance junction-case max	3.33	°C/W	
Rthj-amb	Thermal resistance junction-ambient max	62.5 °C/		
TJ	Maximum lead temperature for soldering purpose	300		



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5.	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250μΑ, V _{GS} =0	60			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max ratings V_{DS} = max ratings, T_{C} = 125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, \ I_D = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_{D} = 8A$		0.08	0.1	Ω

Table 3. On/off states

Table 4.Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V, I _D = 8A		6.5		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1MHz, V _{GS} = 0		315 70 30		pF pF pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 30V, I_D = 8A$ $R_G = 4.7\Omega V_{GS} = 10V$ (see <i>Figure 15</i>)		7 18 17 6		ns ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 48V$, $I_D = 16A$, $V_{GS} = 10V$ (see <i>Figure 16</i>)		10 3.5 3.5	13	nC nC nC

1. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%.



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				16 64	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 16A, V _{GS} = 0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 15A,$ di/dt = 100A/µs, $V_{DD} = 30V, T_j = 150^{\circ}C$ (see <i>Figure 17</i>)		50 88 3.5		ns nC A

Table 5.Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

Figure 1. Safe operating area for TO-220

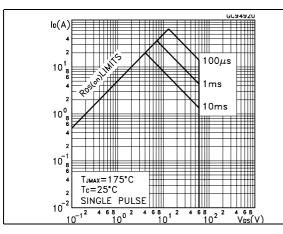
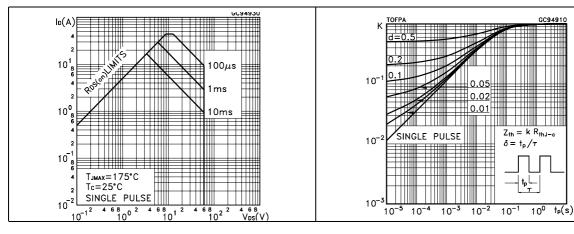
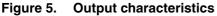


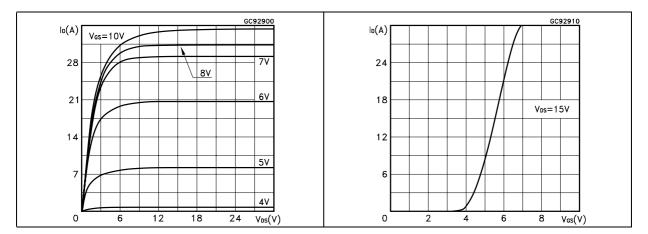
Figure 3. Safe operating area for TO-220FP

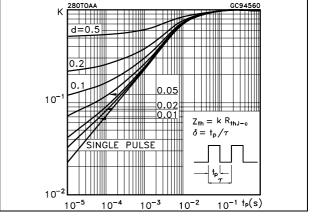






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Thermal impedance for TO-220

Figure 2.

Figure 4. Thermal impedance for TO-220FP

Figure 7. Transconductance

Figure 8. Static drain-source on resistance

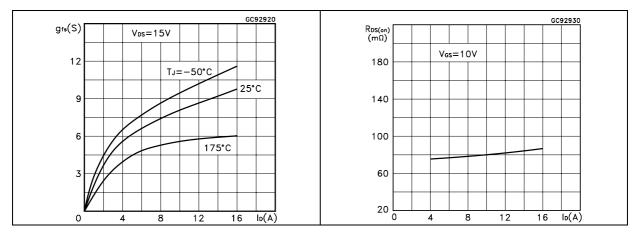
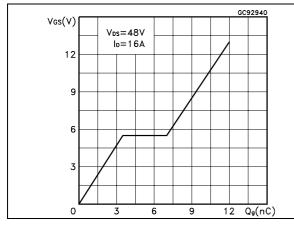


Figure 9. Gate charge vs. gate-source voltage Figure 10. Capacitance variations



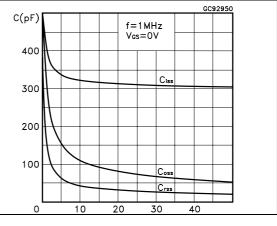


Figure 11. Normalized gate threshold voltage Figure vs. temperature



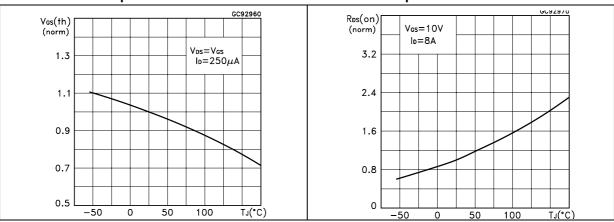
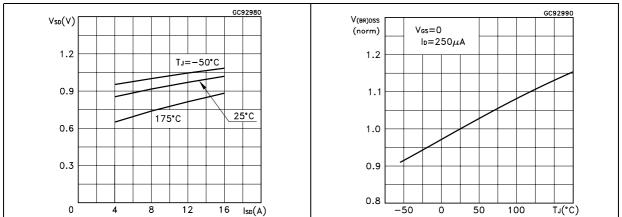


Figure 13. Source-drain diode forward characteristics

Figure 14. Normalized B_{VDSS} vs. temperature





1K Ω

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D.U.T.

SC06000

Test circuit 3

Figure 15. Switching times test circuit for resistive load

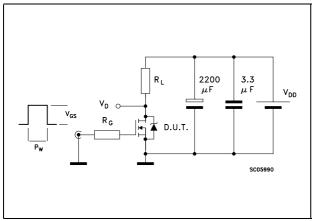
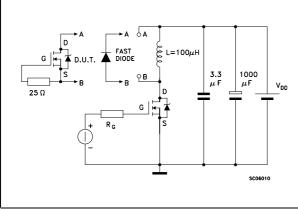


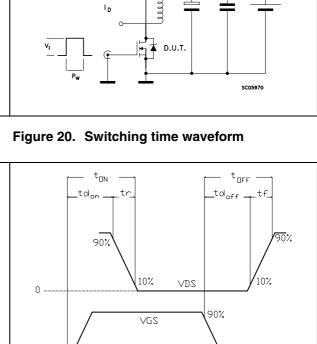
Figure 17. Test circuit for inductive load switching and diode recovery times





circuit

Figure 18. Unclamped Inductive load test



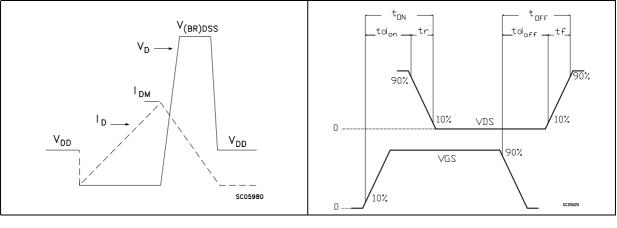


Figure 16. Gate charge test circuit

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 $V_i = 20V = V_{GMAX}$

2200 µF

1ΚΩ

 $V_{\rm D}$

I_G=CONST

()

47KΩ

2.7K Ω

47K Ω

100 Ω

2200

μF

3.3 μF

V_{DD}

∔100nF

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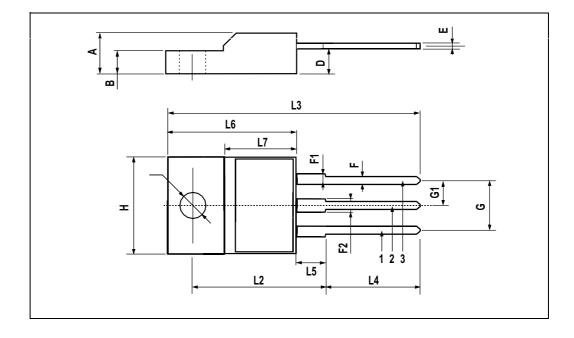
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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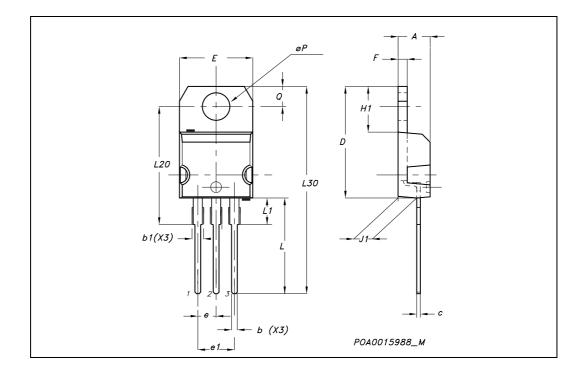
TO-220FP MECHANICAL DATA						
DIM		mm.			inch	
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126





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TO-220 MECHANICAL DATA						
DIM.		mm.			inch	
DIIVI.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
Е	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øР	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



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5 Revision history

Table 6. Revision history

Date	Revision	Changes
09-Sep-2004	4	Preliminary version
28-Jun-2005	5	Complete version
21-Jul-2005	6	ECOPACK label inserted
09-Aug-2006	7	New template, no content change
20-Feb-2007	8	Typo mistake on page 1



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